



RADIO TEST REPORT

Test Report No. : 13261924H-R1

Applicant : **DAIHATSU MOTOR CO., LTD.**
Type of EUT : **Keyfree system**
Model Number of EUT : **DH19S-1**
FCC ID : **2AVSADH19S-1**
Test regulation : **FCC Part 15 Subpart C: 2020**
Test Result : **Complied (Refer to SECTION 3.2)**

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the limits of the above regulation.
4. The test results in this test report are traceable to the national or international standards.
5. This test report covers Radio technical requirements.
It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S. Government.
8. The information provided from the customer for this report is identified in SECTION 1.
9. This report is a revised version of 13261924H. 13261924H is replaced with this report.

Date of test: March 8 and June 30, 2020

Representative test engineer:

Akihiro Maeda
Akihiro Maeda
Engineer
Consumer Technology Division

Approved by:

Motoya Imura
Motoya Imura
Leader
Consumer Technology Division



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☒ There is no testing item of "Non-accreditation".

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REVISION HISTORY

Original Test Report No.: 13261924H

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13261924H	June 30, 2020	-	-
1	13261924H-R1	August 31, 2020	P.7	Update for FCC version
1	13261924H-R1	August 31, 2020	P.10	Correction of the note sentences under the configuration diagram in Clause 4.2; From * The input voltage (DC 12 V) passes through Item No. A without affecting it and is supplied to the antennas (Item No. B to G) without any drop in voltage. To * The input voltage (DC 12 V) passes through Item No. A without affecting it and is supplied to the antennas (Item No. G) without any drop in voltage. For the antenna (Item No. B to F), a fixed voltage is supplied through the regulator.
1	13261924H-R1	August 31, 2020	P.10, 11	Deletion of Cable No.13 from Configuration diagram and cable list in Clause 4.2.
1	13261924H-R1	August 31, 2020	P.6, 10, 11	Correction of Antenna name; From Outside Antenna Back Door / Trunk To Outside Antenna B

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Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	MCS	Modulation and Coding Scheme
AC	Alternating Current	MRA	Mutual Recognition Arrangement
AFH	Adaptive Frequency Hopping	N/A	Not Applicable
AM	Amplitude Modulation	NIST	National Institute of Standards and Technology
Amp, AMP	Amplifier	NS	No signal detect.
ANSI	American National Standards Institute	NSA	Normalized Site Attenuation
Ant, ANT	Antenna	NVLAP	National Voluntary Laboratory Accreditation Program
AP	Access Point	OBW	Occupied Band Width
ASK	Amplitude Shift Keying	OFDM	Orthogonal Frequency Division Multiplexing
Atten., ATT	Attenuator	P/M	Power meter
AV	Average	PCB	Printed Circuit Board
BPSK	Binary Phase-Shift Keying	PER	Packet Error Rate
BR	Bluetooth Basic Rate	PHY	Physical Layer
BT	Bluetooth	PK	Peak
BT LE	Bluetooth Low Energy	PN	Pseudo random Noise
BW	BandWidth	PRBS	Pseudo-Random Bit Sequence
Cal Int	Calibration Interval	PSD	Power Spectral Density
CCK	Complementary Code Keying	QAM	Quadrature Amplitude Modulation
Ch., CH	Channel	QP	Quasi-Peak
CISPR	Comite International Special des Perturbations Radioelectriques	QPSK	Quadri-Phase Shift Keying
CW	Continuous Wave	RBW	Resolution Band Width
DBPSK	Differential BPSK	RDS	Radio Data System
DC	Direct Current	RE	Radio Equipment
D-factor	Distance factor	RF	Radio Frequency
DFS	Dynamic Frequency Selection	RMS	Root Mean Square
DQPSK	Differential QPSK	RSS	Radio Standards Specifications
DSSS	Direct Sequence Spread Spectrum	Rx	Receiving
EDR	Enhanced Data Rate	SA, S/A	Spectrum Analyzer
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	SG	Signal Generator
EMC	ElectroMagnetic Compatibility	SVSWR	Site-Voltage Standing Wave Ratio
EMI	ElectroMagnetic Interference	TR	Test Receiver
EN	European Norm	Tx	Transmitting
ERP, e.r.p.	Effective Radiated Power	VBW	Video BandWidth
EU	European Union	Vert.	Vertical
EUT	Equipment Under Test	WLAN	Wireless LAN
Fac.	Factor		
FCC	Federal Communications Commission		
FHSS	Frequency Hopping Spread Spectrum		
FM	Frequency Modulation		
Freq.	Frequency		
FSK	Frequency Shift Keying		
GFSK	Gaussian Frequency-Shift Keying		
GNSS	Global Navigation Satellite System		
GPS	Global Positioning System		
Hori.	Horizontal		
ICES	Interference-Causing Equipment Standard		
IEC	International Electrotechnical Commission		
IEEE	Institute of Electrical and Electronics Engineers		
IF	Intermediate Frequency		
ILAC	International Laboratory Accreditation Conference		
ISED	Innovation, Science and Economic Development Canada		
ISO	International Organization for Standardization		
JAB	Japan Accreditation Board		
LAN	Local Area Network		
LIMS	Laboratory Information Management System		

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SECTION 1: Customer information

Company Name	:	DAIHATSU MOTOR CO., LTD.*
Address	:	2-1-1, Momozono, Ikeda-shi, Osaka, 563-8651, Japan
Telephone Number	:	+81-72-754-4526
Facsimile Number	:	+81-72-754-3857
Contact Person	:	Hideshige Nakano

***Remarks:**

DAIHATSU MOTOR CO., LTD. designates DENSO CORPORATION and TOKAI RIKA CO., LTD. as manufacturer of the product (Immobilizer).

The information provided from the customer is as follows;

- Applicant, Type of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (EUT) other than the Receipt Date
- SECTION 4: Operation of EUT during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (EUT)

2.1 Identification of EUT

Type	:	Keyfree system
Model Number	:	DH19S-1
Serial Number	:	Refer to SECTION 4.2
Rating	:	DC 12.0 V
Receipt Date	:	March 3, 2020
Country of Mass-production	:	Malaysia and Republic of Indonesia
Condition	:	Production prototype
		(Not for Sale: This sample is equivalent to mass-produced items.)
Modification	:	No Modification by the test lab

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2.2 Product Description

Model: DH19S-1 (referred to as the EUT in this report) is a Keyfree system.

Radio Specification

[Transmitter part]

Radio Type	:	LF Transmitter
Frequency of Operation	:	125 kHz
Oscillation circuit	:	Ceramic resonator
Oscillator frequency	:	4 MHz
Modulation	:	ASK
Antenna type	:	Antenna (Outside Antenna D) Antenna (Outside Antenna P) Antenna (Outside Antenna B) Antenna (Inside Antenna Fr) Antenna (Inside Antenna Rr) Immobilizer Antenna
Antenna Specification	:	Antenna (Outside, Inside): Ferrite antenna coil Immobilizer Antenna: Loop antenna coil
Clock Frequency (maximum)	:	MPU: 8 MHz

[Receiver part]

Frequency of Operation	:	433.92 MHz
Oscillator frequency	:	33.600 MHz (Crystal)
Intermediate frequency	:	525 kHz
Modulation	:	FSK
Type of receiving system	:	Super-heterodyne
Antenna Specification	:	Internal antenna (Inverted F antenna)
Receiver Bandwidth	:	120 kHz

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on June 26, 2020 and effective July 27, 2020

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.209 Radiated emission limits; general requirements.

- * The revision does not affect the test result conducted before its effective date.
- * Also the EUT complies with FCC Part 15 Subpart B.

3.2 Procedures and results

Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results	Remarks
Conducted Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <ISED> RSS-Gen 8.8	<FCC> Section 15.207 <ISED> RSS-Gen 8.8	-	N/A	N/A	N/A	*1)
Electric Field Strength of Fundamental Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <ISED> RSS-Gen 6.5, 6.12	<FCC> Section 15.209 <ISED> RSS-210 4.4 RSS-Gen 8.9	Radiated	N/A	13.6 dB 125 kHz 0 deg. Peak with Duty factor	Complied a)	-
Electric Field Strength of Spurious Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <ISED> RSS-Gen 6.5, 6.6, 6.13	<FCC> Section 15.209 <ISED> RSS-210 4.4 RSS-Gen 8.9	Radiated	N/A	6.1 dB 32.312 MHz, Vertical	Complied a)	-
-26 dB Bandwidth	<FCC> ANSI C63.10:2013 6 Standard test methods <ISED> -	<FCC> Reference data <ISED> -	Radiated	N/A	N/A	Complied b)	-

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT is not the device that is designed to be connected to the public utility (AC) power line.

a) Refer to APPENDIX 1 (data of Radiated emission)

b) Refer to APPENDIX 1 (data of -26 dB Bandwidth and 99 % Occupied Bandwidth)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

FCC Part 15.31 (e)

The battery voltage (DC 12V) is provided to the EUT. Input voltage to RF part doesn't go through the regulator. So the test was performed with the supply voltage varied between 85 % and 115% of the nominal rated supply voltage (DC 12 V) and the variation of the input power does not affect the test result, therefore the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the vehicle. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
99 % Occupied Band Width	RSS-Gen 6.7	-	Radiated	N/A	N/A	-

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)
3 m	9 kHz to 30 MHz	3.3 dB
10 m		3.2 dB
3 m	30 MHz to 200 MHz (Horizontal)	4.8 dB
		5.0 dB
	200 MHz to 1000 MHz (Horizontal)	5.2 dB
		6.3 dB
10 m	30 MHz to 200 MHz (Horizontal)	4.8 dB
		4.8 dB
	200 MHz to 1000 MHz (Horizontal)	5.0 dB
		5.0 dB

Antenna Terminal test

Test Item	Uncertainty (+/-)
-26 dB Bandwidth / 99 % Occupied Bandwidth	0.96 %

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3.5 Test Location

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*NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967 / ISED Lab Company Number: 2973C

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Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

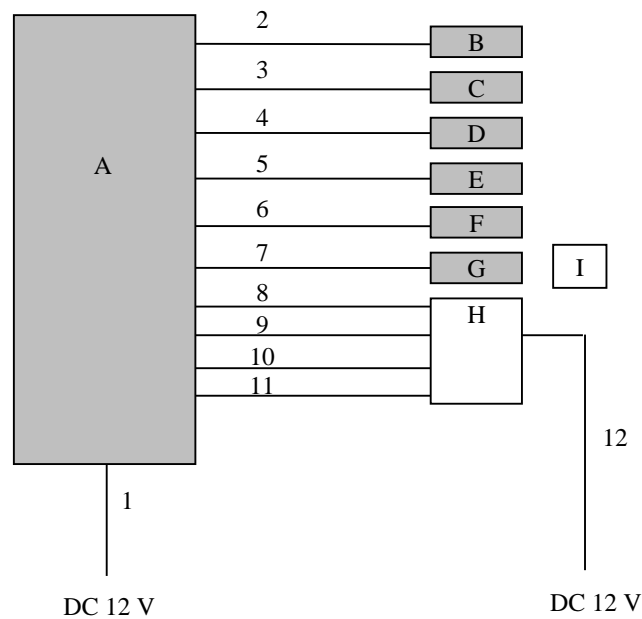
SECTION 4: Operation of EUT during testing

4.1 Operating Modes

Test mode	Remarks
1) Tx 125 kHz Outside Antenna D	-
2) Tx 125 kHz Outside Antenna P	-
3) Tx 125 kHz Outside Antenna B	-
4) Tx 125 kHz Inside Antenna Fr	-
5) Tx 125 kHz Inside Antenna Rr	-
6) Tx 125 kHz Immobilizer Antenna	-
* EUT was set by the software as follows; Software: 200213_RadioTest_TypeA.s (Date: February 13, 2020, Storage location: IC0001) *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	

Justification : The system was configured in typical fashion (as a user would normally use it) for testing.

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

* The input voltage (DC 12 V) passes through Item No. A without affecting it and is supplied to the antennas (Item No. G) without any drop in voltage.

For the antenna (Item No. B to F), a fixed voltage is supplied through the regulator.

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Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Body ECU	DH19S-1	No. 237	DENSO CORPORATION	EUT
B	Antenna	Outside Antenna D	No.237-1	TOKAIRIKA CO.,LTD.	EUT
C	Antenna	Outside Antenna P	No.237-2	TOKAIRIKA CO.,LTD.	EUT
D	Antenna	Outside Antenna B	No.237-3	TOKAIRIKA CO.,LTD.	EUT
E	Antenna	Inside Antenna Fr	No.237-4	TOKAIRIKA CO.,LTD.	EUT
F	Antenna	Inside Antenna Rr	No.237-5	TOKAIRIKA CO.,LTD.	EUT
G	Antenna	Immobilizer Antenna	No. 237	TOKAIRIKA CO.,LTD.	EUT
H	Evaluation Bench	-	-	DENSO CORPORATION	-
I	Smart Key	-	No. 237	DENSO CORPORATION	-

List of cables used

No.	Name	Length (m)	Shield		Remark
			Cable	Connector	
1	DC Cable	3.0	Unshielded	Unshielded	-
2	Antenna Cable (AND)	3.0	Unshielded	Unshielded	-
3	Antenna Cable (ANP)	3.0	Unshielded	Unshielded	-
4	Antenna Cable (ANB)	3.0	Unshielded	Unshielded	-
5	Antenna Cable (ANF)	3.0	Unshielded	Unshielded	-
6	Antenna Cable (ANR)	3.0	Unshielded	Unshielded	-
7	Antenna Cable	3.0	Unshielded	Unshielded	-
8	Signal Cable (CN-C)	3.0	Unshielded	Unshielded	-
9	Signal Cable (CN-K)	3.0	Unshielded	Unshielded	-
10	Signal Cable (CN-M)	3.0	Unshielded	Unshielded	-
11	Signal Cable (CN-P)	3.0	Unshielded	Unshielded	-
12	DC Cable	3.0	Unshielded	Unshielded	-

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SECTION 5: Radiated emission (Fundamental and Spurious Emission)

Test Procedure

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

Frequency : From 9 kHz to 30 MHz

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg., and 135 deg.) and horizontal polarization.

*Refer to Figure 1 about Direction of the Loop Antenna.

Frequency: From 30 MHz to 1 GHz

The measuring antenna height varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

The test was made with the detector (RBW / VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz
Antenna Type	Loop	Biconical	Logperiodic

Frequency	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz
Instrument used	Test Receiver				
Detector	PK / AV	QP	PK / AV	QP	QP
IF Bandwidth	200 Hz	200 Hz	9 kHz	9 kHz	120 kHz
Test Distance	10 m *1)	10 m *1)	10 m *1)	10 m *2)	3 m

*1) Distance Factor: $40 \times \log (10 \text{ m} / 300 \text{ m}) = -59.1 \text{ dB}$

*2) Distance Factor: $40 \times \log (10 \text{ m} / 30 \text{ m}) = -19.1 \text{ dB}$

Although these tests were performed other than open field test site, adequate comparison measurements were confirmed against 30 m open field test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788.

These tests were performed in semi anechoic chamber. Therefore the measured level of emissions may be higher than if measurements were made without a ground plane.

However test results were confirmed to pass against standard limit.

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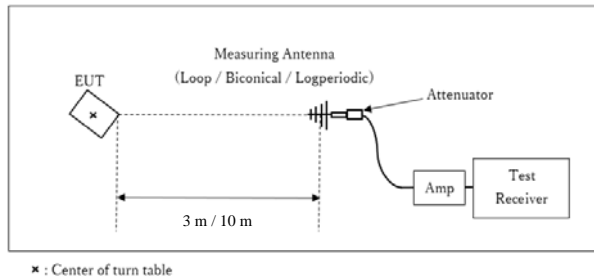
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[Test Setup]
Below 1 GHz



Test Distance: 3 m / 10 m

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

This EUT has two modes which transponder key is inserted or not. The worst case was confirmed with and without transponder key, as a result, the test without transponder key was the worst case. Therefore the test without transponder key was performed only.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 9 kHz - 1 GHz
Test data : APPENDIX 1
Test result : Pass

Date: March 8, 2020

Test engineer: Akihiko Maeda

UL Japan, Inc.

Ise EMC Lab.

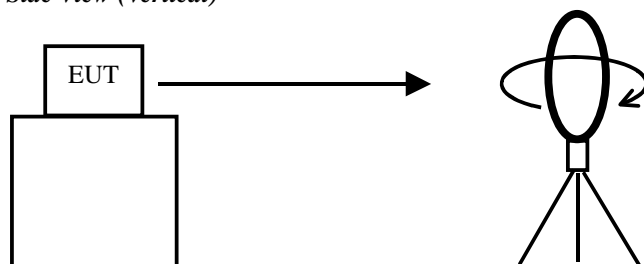
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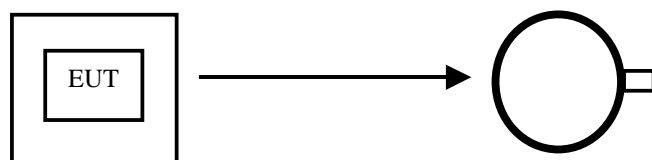
Figure 1: Direction of the Loop Antenna

Side View (Vertical)



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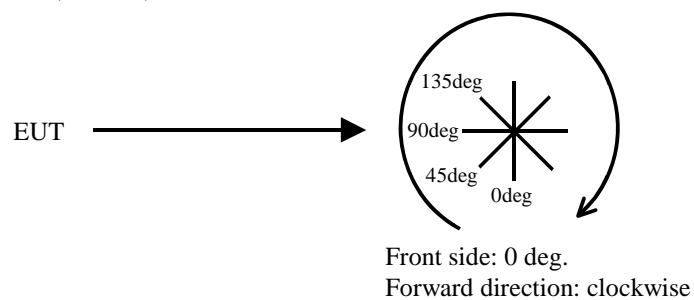
Top View (Horizontal)



Antenna was not rotated.

.....

Top View (Vertical)



SECTION 6: -26 dB Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
-26 dB Bandwidth	75 kHz	510 Hz	1.6 kHz	Auto	Peak	Max Hold	Spectrum Analyzer

Test data : APPENDIX 1

Test result : Pass

SECTION 7: 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer

*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100 %.
Peak hold was applied as Worst-case measurement.

Test data : APPENDIX 1

Test result : Pass

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APPENDIX 1: Test data

Radiated Emission below 30 MHz (Fundamental and Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date March 8, 2020 No.1
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda
Mode Mode 1 Akihiko Maeda

PK or QP

Ant Deg [deg] or Polarity [Hori/Vert]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	PK	76.4	19.9	-53.0	32.3	-	11.0	45.6	34.6	Fundamental (DC 10.2 V)
0deg	0.12500	PK	76.4	19.9	-53.0	32.3	-	11.0	45.6	34.6	Fundamental (DC 12.0 V)
0deg	0.12500	PK	76.4	19.9	-53.0	32.3	-	11.0	45.6	34.6	Fundamental (DC 13.8 V)
0deg	0.25000	PK	41.6	19.9	-53.0	32.3	-	-23.8	39.6	63.4	
0deg	0.37500	PK	40.1	19.9	-52.9	32.3	-	-25.3	36.1	61.4	
0deg	0.50000	QP	32.7	19.8	-12.9	32.2	-	7.4	33.6	26.2	
0deg	0.62500	QP	32.1	19.8	-12.9	32.2	-	6.8	31.7	25.0	
0deg	0.75000	QP	31.6	19.8	-12.9	32.3	-	6.3	30.1	23.8	
0deg	0.87500	QP	31.3	19.8	-12.9	32.3	-	6.0	28.7	22.8	
0deg	1.00000	QP	30.9	19.8	-12.8	32.3	-	5.5	27.6	22.1	
0deg	1.12500	QP	30.8	19.8	-12.8	32.3	-	5.5	26.5	21.0	
0deg	1.25000	QP	30.8	19.8	-12.8	32.3	-	5.5	25.6	20.1	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

PK with Duty factor

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	AV	76.4	19.9	-53.0	32.3	0.0	11.0	25.6	14.6	DC 10.2 V
0deg	0.12500	AV	76.4	19.9	-53.0	32.3	0.0	11.0	25.6	14.6	DC 12.0 V
0deg	0.12500	AV	76.4	19.9	-53.0	32.3	0.0	11.0	25.6	14.6	DC 13.8 V
0deg	0.25000	AV	41.6	19.9	-53.0	32.3	0.0	-23.8	19.6	43.4	
0deg	0.37500	AV	40.1	19.9	-52.9	32.3	0.0	-25.3	16.1	41.4	

Result of the fundamental emission at 10m without Distance factor

PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	76.4	19.9	6.1	32.3	-	70.1	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

- *It was confirmed that there was no difference by the input voltage in the spurious emission.
- * Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).
- *The test result is rounded off to one or two decimal places, so some differences might be observed.

UL Japan, Inc.

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Radiated Emission below 30 MHz (Fundamental and Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date March 8, 2020 No.1
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda Akihiko Maeda
Mode Mode 2

PK or QP

Ant Deg [deg] or Polarity [Hori/Vert]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	PK	76.6	19.9	-53.0	32.3	-	11.2	45.6	34.4	Fundamental (DC 10.2 V)
0deg	0.12500	PK	76.6	19.9	-53.0	32.3	-	11.2	45.6	34.4	Fundamental (DC 12.0 V)
0deg	0.12500	PK	76.6	19.9	-53.0	32.3	-	11.2	45.6	34.4	Fundamental (DC 13.8 V)
0deg	0.25000	PK	42.6	19.9	-53.0	32.3	-	-22.8	39.6	62.4	
0deg	0.37500	PK	40.9	19.9	-52.9	32.3	-	-24.5	36.1	60.6	
0deg	0.50000	QP	32.7	19.8	-12.9	32.2	-	7.4	33.6	26.2	
0deg	0.62500	QP	31.9	19.8	-12.9	32.2	-	6.6	31.7	25.2	
0deg	0.75000	QP	31.5	19.8	-12.9	32.3	-	6.2	30.1	23.9	
0deg	0.87500	QP	31.3	19.8	-12.9	32.3	-	6.0	28.7	22.8	
0deg	1.00000	QP	31.0	19.8	-12.8	32.3	-	5.6	27.6	22.0	
0deg	1.12500	QP	30.8	19.8	-12.8	32.3	-	5.5	26.5	21.0	
0deg	1.25000	QP	30.7	19.8	-12.8	32.3	-	5.4	25.6	20.2	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

PK with Duty factor

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	AV	76.6	19.9	-53.0	32.3	0.0	11.2	25.6	14.4	DC 10.2 V
0deg	0.12500	AV	76.6	19.9	-53.0	32.3	0.0	11.2	25.6	14.4	DC 12.0 V
0deg	0.12500	AV	76.6	19.9	-53.0	32.3	0.0	11.2	25.6	14.4	DC 13.8 V
0deg	0.25000	AV	42.6	19.9	-53.0	32.3	0.0	-22.8	19.6	42.4	
0deg	0.37500	AV	40.9	19.9	-52.9	32.3	0.0	-24.5	16.1	40.6	

Result of the fundamental emission at 10m without Distance factor

PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	76.6	19.9	6.1	32.3	-	70.3	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

*It was confirmed that there was no difference by the input voltage in the spurious emission.

* Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB)*The test result is rounded off to one or two decimal places, so some differences might be observed.

UL Japan, Inc.

Ise EMC Lab.

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Facsimile : +81 596 24 8124

Radiated Emission below 30 MHz (Fundamental and Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date March 8, 2020 No.1
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda Akihiko Maeda
Mode Mode 3

PK or QP

Ant Deg [deg] or Polarity [Hori/Vert]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	PK	77.3	19.9	-53.0	32.3	-	11.9	45.6	33.7	Fundamental (DC 10.2 V)
0deg	0.12500	PK	77.3	19.9	-53.0	32.3	-	11.9	45.6	33.7	Fundamental (DC 12.0 V)
0deg	0.12500	PK	77.3	19.9	-53.0	32.3	-	11.9	45.6	33.7	Fundamental (DC 13.8 V)
0deg	0.25000	PK	42.2	19.9	-53.0	32.3	-	-23.2	39.6	62.8	
0deg	0.37500	PK	40.9	19.9	-52.9	32.3	-	-24.5	36.1	60.6	
0deg	0.50000	QP	32.6	19.8	-12.9	32.2	-	7.3	33.6	26.3	
0deg	0.62500	QP	32.1	19.8	-12.9	32.2	-	6.8	31.7	25.0	
0deg	0.75000	QP	31.5	19.8	-12.9	32.3	-	6.2	30.1	23.9	
0deg	0.87500	QP	31.2	19.8	-12.9	32.3	-	5.9	28.7	22.9	
0deg	1.00000	QP	31.0	19.8	-12.8	32.3	-	5.6	27.6	22.0	
0deg	1.12500	QP	31.0	19.8	-12.8	32.3	-	5.7	26.5	20.8	
0deg	1.25000	QP	30.8	19.8	-12.8	32.3	-	5.5	25.6	20.1	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

PK with Duty factor

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	AV	77.3	19.9	-53.0	32.3	0.0	11.9	25.6	13.7	DC 10.2 V
0deg	0.12500	AV	77.3	19.9	-53.0	32.3	0.0	11.9	25.6	13.7	DC 12.0 V
0deg	0.12500	AV	77.3	19.9	-53.0	32.3	0.0	11.9	25.6	13.7	DC 13.8 V
0deg	0.25000	AV	42.2	19.9	-53.0	32.3	0.0	-23.2	19.6	42.8	
0deg	0.37500	AV	40.9	19.9	-52.9	32.3	0.0	-24.5	16.1	40.6	

Result of the fundamental emission at 10m without Distance factor

PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	77.3	19.9	6.1	32.3	-	71.0	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

- *It was confirmed that there was no difference by the input voltage in the spurious emission.
- * Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).
- *The test result is rounded off to one or two decimal places, so some differences might be observed.

UL Japan, Inc.

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Radiated Emission below 30 MHz (Fundamental and Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date March 8, 2020 No.1
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda
Mode Mode 4

PK or QP

Ant Deg [deg] or Polarity [Hori/Vert]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	PK	76.6	19.9	-53.0	32.3	-	11.2	45.6	34.4	Fundamental (DC 10.2 V)
0deg	0.12500	PK	76.6	19.9	-53.0	32.3	-	11.2	45.6	34.4	Fundamental (DC 12.0 V)
0deg	0.12500	PK	76.6	19.9	-53.0	32.3	-	11.2	45.6	34.4	Fundamental (DC 13.8 V)
0deg	0.25000	PK	42.2	19.9	-53.0	32.3	-	-23.2	39.6	62.8	
0deg	0.37500	PK	40.5	19.9	-52.9	32.3	-	-24.9	36.1	61.0	
0deg	0.50000	QP	32.7	19.8	-12.9	32.2	-	7.4	33.6	26.2	
0deg	0.62500	QP	32.1	19.8	-12.9	32.2	-	6.8	31.7	25.0	
0deg	0.75000	QP	31.5	19.8	-12.9	32.3	-	6.2	30.1	23.9	
0deg	0.87500	QP	31.3	19.8	-12.9	32.3	-	6.0	28.7	22.8	
0deg	1.00000	QP	31.0	19.8	-12.8	32.3	-	5.6	27.6	22.0	
0deg	1.12500	QP	30.9	19.8	-12.8	32.3	-	5.6	26.5	20.9	
0deg	1.25000	QP	30.8	19.8	-12.8	32.3	-	5.5	25.6	20.1	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

PK with Duty factor

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	AV	76.6	19.9	-53.0	32.3	0.0	11.2	25.6	14.4	DC 10.2 V
0deg	0.12500	AV	76.6	19.9	-53.0	32.3	0.0	11.2	25.6	14.4	DC 12.0 V
0deg	0.12500	AV	76.6	19.9	-53.0	32.3	0.0	11.2	25.6	14.4	DC 13.8 V
0deg	0.25000	AV	42.2	19.9	-53.0	32.3	0.0	-23.2	19.6	42.8	
0deg	0.37500	AV	40.5	19.9	-52.9	32.3	0.0	-24.9	16.1	41.0	

Result of the fundamental emission at 10m without Distance factor

PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	76.6	19.9	6.1	32.3	-	70.3	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

- *It was confirmed that there was no difference by the input voltage in the spurious emission.
- * Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).
- *The test result is rounded off to one or two decimal places, so some differences might be observed.

UL Japan, Inc.

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Radiated Emission below 30 MHz (Fundamental and Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date March 8, 2020 No.1
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda Akihiko Maeda
Mode Mode 5

PK or QP

Ant Deg [deg] or Polarity [Hori/Vert]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	PK	77.4	19.9	-53.0	32.3	-	12.0	45.6	33.6	Fundamental (DC 10.2 V)
0deg	0.12500	PK	77.4	19.9	-53.0	32.3	-	12.0	45.6	33.6	Fundamental (DC 12.0 V)
0deg	0.12500	PK	77.4	19.9	-53.0	32.3	-	12.0	45.6	33.6	Fundamental (DC 13.8 V)
0deg	0.25000	PK	41.8	19.9	-53.0	32.3	-	-23.6	39.6	63.2	
0deg	0.37500	PK	40.2	19.9	-52.9	32.3	-	-25.2	36.1	61.3	
0deg	0.50000	QP	32.6	19.8	-12.9	32.2	-	7.3	33.6	26.3	
0deg	0.62500	QP	32.1	19.8	-12.9	32.2	-	6.8	31.7	25.0	
0deg	0.75000	QP	31.6	19.8	-12.9	32.3	-	6.3	30.1	23.8	
0deg	0.87500	QP	31.3	19.8	-12.9	32.3	-	6.0	28.7	22.8	
0deg	1.00000	QP	31.0	19.8	-12.8	32.3	-	5.6	27.6	22.0	
0deg	1.12500	QP	30.9	19.8	-12.8	32.3	-	5.6	26.5	20.9	
0deg	1.25000	QP	30.9	19.8	-12.8	32.3	-	5.6	25.6	20.0	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

PK with Duty factor

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	AV	77.4	19.9	-53.0	32.3	0.0	12.0	25.6	13.6	DC 10.2 V
0deg	0.12500	AV	77.4	19.9	-53.0	32.3	0.0	12.0	25.6	13.6	DC 12.0 V
0deg	0.12500	AV	77.4	19.9	-53.0	32.3	0.0	12.0	25.6	13.6	DC 13.8 V
0deg	0.25000	AV	41.8	19.9	-53.0	32.3	0.0	-23.6	19.6	43.2	
0deg	0.37500	AV	40.2	19.9	-52.9	32.3	0.0	-25.2	16.1	41.3	

Result of the fundamental emission at 10m without Distance factor

PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	77.4	19.9	6.1	32.3	-	71.1	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

*It was confirmed that there was no difference by the input voltage in the spurious emission.

* Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

UL Japan, Inc.

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Radiated Emission below 30 MHz (Fundamental and Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date March 8, 2020 No.1
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda Akihiko Maeda
Mode Mode 6

PK or QP

Ant Deg [deg] or Polarity [Hori/Vert]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	PK	60.4	19.9	-53.0	32.3	-	-5.0	45.6	50.6	Fundamental (DC 10.2 V)
0deg	0.12500	PK	60.4	19.9	-53.0	32.3	-	-5.0	45.6	50.6	Fundamental (DC 12.0 V)
0deg	0.12500	PK	60.4	19.9	-53.0	32.3	-	-5.0	45.6	50.6	Fundamental (DC 13.8 V)
0deg	0.25000	PK	42.4	19.9	-53.0	32.3	-	-23.0	39.6	62.6	
0deg	0.37500	PK	40.9	19.9	-52.9	32.3	-	-24.5	36.1	60.6	
0deg	0.50000	QP	32.7	19.8	-12.9	32.2	-	7.4	33.6	26.2	
0deg	0.62500	QP	32.0	19.8	-12.9	32.2	-	6.7	31.7	25.1	
0deg	0.75000	QP	31.4	19.8	-12.9	32.3	-	6.1	30.1	24.0	
0deg	0.87500	QP	31.2	19.8	-12.9	32.3	-	5.9	28.7	22.9	
0deg	1.00000	QP	31.0	19.8	-12.8	32.3	-	5.6	27.6	22.0	
0deg	1.12500	QP	30.9	19.8	-12.8	32.3	-	5.6	26.5	20.9	
0deg	1.25000	QP	30.6	19.8	-12.8	32.3	-	5.3	25.6	20.3	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

PK with Duty factor

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.12500	AV	60.4	19.9	-53.0	32.3	0.0	-5.0	25.6	30.6	DC 10.2 V
0deg	0.12500	AV	60.4	19.9	-53.0	32.3	0.0	-5.0	25.6	30.6	DC 12.0 V
0deg	0.12500	AV	60.4	19.9	-53.0	32.3	0.0	-5.0	25.6	30.6	DC 13.8 V
0deg	0.25000	AV	42.4	19.9	-53.0	32.3	0.0	-23.0	19.6	42.6	
0deg	0.37500	AV	40.9	19.9	-52.9	32.3	0.0	-24.5	16.1	40.6	

Result of the fundamental emission at 10m without Distance factor

PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	60.4	19.9	6.1	32.3	-	54.1	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

*It was confirmed that there was no difference by the input voltage in the spurious emission.

* Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

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Radiated Emission above 30 MHz (Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1 No.1
Date March 8, 2020 June 30, 2020
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda Akihiko Maeda
Mode Mode 1

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	34.882	QP	28.9	16.6	7.5	38.8	14.1	40.0	25.9	
Hori.	50.562	QP	35.6	10.8	7.8	38.8	15.4	40.0	24.6	
Hori.	62.576	QP	40.7	7.3	8.0	38.8	17.1	40.0	22.9	
Hori.	126.618	QP	43.1	13.3	8.9	38.9	26.4	43.5	17.1	
Hori.	139.623	QP	36.9	14.4	9.1	38.9	21.5	43.5	22.0	
Hori.	390.867	QP	38.8	15.5	11.5	38.5	27.2	46.0	18.8	
Vert.	34.882	QP	35.9	16.6	7.5	38.8	21.1	40.0	18.9	
Vert.	50.562	QP	49.0	10.8	7.8	38.8	28.8	40.0	11.2	
Vert.	62.576	QP	49.9	7.3	8.0	38.8	26.3	40.0	13.7	
Vert.	126.618	QP	45.6	13.3	8.9	38.9	28.9	43.5	14.6	
Vert.	139.623	QP	41.9	14.4	9.1	38.9	26.5	43.5	17.0	
Vert.	390.867	QP	34.5	15.5	11.5	38.5	22.9	46.0	23.1	

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*It was confirmed that there was no difference by the input voltage in the spurious emission.

UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Radiated Emission above 30 MHz (Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1 No.1
Date March 8, 2020 June 30, 2020
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda Akihiko Maeda
Mode Mode 2

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	31.178	QP	38.7	17.9	7.4	38.8	25.2	40.0	14.8	
Hori.	34.814	QP	36.2	16.6	7.5	38.8	21.5	40.0	18.5	
Hori.	50.549	QP	36.2	10.8	7.8	38.8	16.0	40.0	24.0	
Hori.	58.191	QP	38.9	8.3	7.9	38.8	16.3	40.0	23.7	
Hori.	127.629	QP	42.8	13.5	9.0	38.9	26.3	43.5	17.2	
Hori.	388.899	QP	41.5	15.4	11.4	38.5	29.8	46.0	16.2	
Vert.	31.178	QP	47.2	17.9	7.4	38.8	33.7	40.0	6.3	
Vert.	34.814	QP	47.9	16.6	7.5	38.8	33.2	40.0	6.8	
Vert.	50.549	QP	49.2	10.8	7.8	38.8	29.0	40.0	11.0	
Vert.	58.191	QP	46.2	8.3	7.9	38.8	23.6	40.0	16.4	
Vert.	127.629	QP	45.0	13.5	9.0	38.9	28.5	43.5	15.0	
Vert.	388.899	QP	38.5	15.4	11.4	38.5	26.8	46.0	19.2	

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*It was confirmed that there was no difference by the input voltage in the spurious emission.

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Radiated Emission above 30 MHz (Spurious Emission)

Report No. 13261924H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date March 8, 2020 No.1
Temperature / Humidity 22 deg. C / 47 % RH 23 deg. C / 62 % RH
Engineer Akihiko Maeda Akihiko Maeda
Mode Mode 3

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	35.146	QP	29.1	16.5	7.5	38.8	14.2	40.0	25.8	
Hori.	49.522	QP	35.0	11.2	7.8	38.8	15.2	40.0	24.8	
Hori.	51.544	QP	35.9	10.5	7.8	38.8	15.4	40.0	24.6	
Hori.	104.602	QP	39.4	10.8	8.7	39.0	19.9	43.5	23.6	
Hori.	130.616	QP	41.8	13.7	9.0	38.9	25.6	43.5	17.9	
Hori.	377.873	QP	42.5	15.2	11.4	38.5	30.5	46.0	15.5	
Vert.	35.146	QP	35.9	16.5	7.5	38.8	21.0	40.0	19.0	
Vert.	49.522	QP	48.9	11.2	7.8	38.8	29.1	40.0	10.9	
Vert.	51.544	QP	49.9	10.5	7.8	38.8	29.4	40.0	10.6	
Vert.	104.602	QP	46.2	10.8	8.7	39.0	26.7	43.5	16.8	
Vert.	130.616	QP	44.2	13.7	9.0	38.9	28.0	43.5	15.5	
Vert.	377.873	QP	38.9	15.2	11.4	38.5	26.9	46.0	19.1	

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*It was confirmed that there was no difference by the input voltage in the spurious emission.

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Radiated Emission above 30 MHz (Spurious Emission)

Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 4	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	34.551	QP	29.2	16.7	7.5	38.8	14.6	40.0	25.5	
Hori.	48.551	QP	33.6	11.5	7.8	38.8	14.1	40.0	25.9	
Hori.	50.556	QP	35.6	10.8	7.8	38.8	15.4	40.0	24.6	
Hori.	60.563	QP	40.0	7.6	8.0	38.8	16.8	40.0	23.2	
Hori.	129.607	QP	43.0	13.7	9.0	38.9	26.8	43.5	16.7	
Hori.	398.891	QP	42.5	15.7	11.5	38.5	31.2	46.0	14.8	
Vert.	34.551	QP	38.9	16.7	7.5	38.8	24.3	40.0	15.8	
Vert.	48.551	QP	46.4	11.5	7.8	38.8	26.9	40.0	13.1	
Vert.	50.556	QP	49.1	10.8	7.8	38.8	28.9	40.0	11.1	
Vert.	60.563	QP	49.7	7.6	8.0	38.8	26.5	40.0	13.5	
Vert.	129.607	QP	46.2	13.7	9.0	38.9	30.0	43.5	13.5	
Vert.	398.891	QP	32.8	15.7	11.5	38.5	21.5	46.0	24.5	

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*It was confirmed that there was no difference by the input voltage in the spurious emission.

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Radiated Emission above 30 MHz (Spurious Emission)

Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 5	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	32.312	QP	41.5	17.6	7.4	38.8	27.7	40.0	12.3	
Hori.	34.610	QP	34.2	16.7	7.5	38.8	19.5	40.0	20.5	
Hori.	53.723	QP	37.4	9.7	7.9	38.8	16.2	40.0	23.9	
Hori.	62.985	QP	42.3	7.2	8.0	38.8	18.7	40.0	21.3	
Hori.	123.617	QP	41.2	13.2	8.9	39.0	24.3	43.5	19.2	
Hori.	385.877	QP	41.3	15.3	11.4	38.5	29.5	46.0	16.5	
Vert.	32.312	QP	47.7	17.6	7.4	38.8	33.9	40.0	6.1	
Vert.	34.610	QP	46.6	16.7	7.5	38.8	31.9	40.0	8.1	
Vert.	53.723	QP	51.8	9.7	7.9	38.8	30.6	40.0	9.5	
Vert.	62.985	QP	49.5	7.2	8.0	38.8	25.9	40.0	14.1	
Vert.	123.617	QP	47.2	13.2	8.9	39.0	30.3	43.5	13.2	
Vert.	385.877	QP	37.3	15.3	11.4	38.5	25.5	46.0	20.5	

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*It was confirmed that there was no difference by the input voltage in the spurious emission.

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Radiated Emission above 30 MHz (Spurious Emission)

Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 6	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	44.043	QP	29.4	13.2	7.7	38.8	11.5	40.0	28.5	
Hori.	136.124	QP	28.5	14.2	9.1	38.9	12.9	43.5	30.7	
Hori.	188.173	QP	28.9	16.3	9.7	38.9	15.9	43.5	27.6	
Hori.	292.283	QP	38.7	13.5	10.7	38.8	24.1	46.0	21.9	
Hori.	356.321	QP	30.0	15.0	11.2	38.6	17.6	46.0	28.4	
Hori.	420.380	QP	30.8	16.1	11.7	38.5	20.1	46.0	25.9	
Vert.	44.043	QP	40.5	13.2	7.7	38.8	22.6	40.0	17.4	
Vert.	136.124	QP	35.7	14.2	9.1	38.9	20.1	43.5	23.5	
Vert.	188.173	QP	32.5	16.3	9.7	38.9	19.5	43.5	24.0	
Vert.	292.283	QP	35.1	13.5	10.7	38.8	20.5	46.0	25.5	
Vert.	356.321	QP	27.7	15.0	11.2	38.6	15.3	46.0	30.7	
Vert.	420.380	QP	30.4	16.1	11.7	38.5	19.7	46.0	26.3	

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*It was confirmed that there was no difference by the input voltage in the spurious emission.

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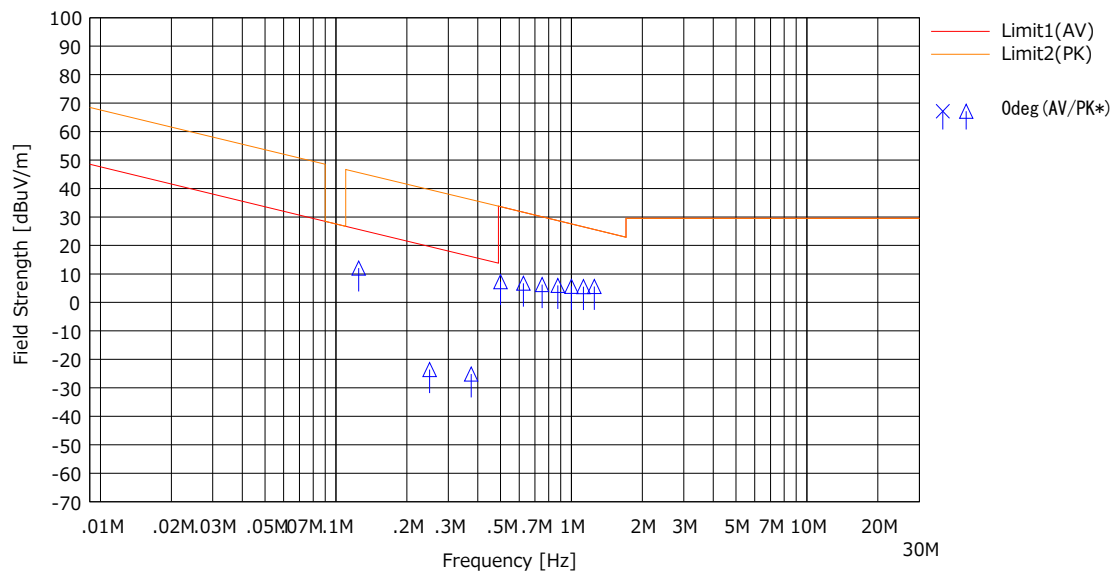
Facsimile : +81 596 24 8124

Radiated Emission Plot data, Worst case

Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 5	

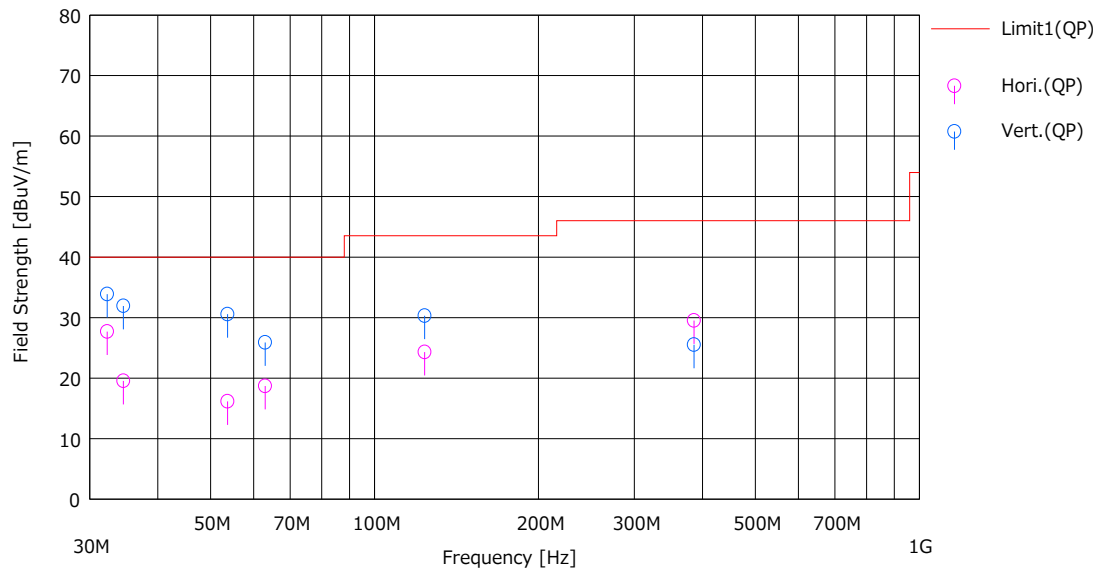
(below 30MHz)

Limit : FCC15.209(a), 9-90kHz:PK, 110-490kHz:PK, other:QP



* Data above 490 kHz were measured using a QP detector.

(above 30MHz)



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

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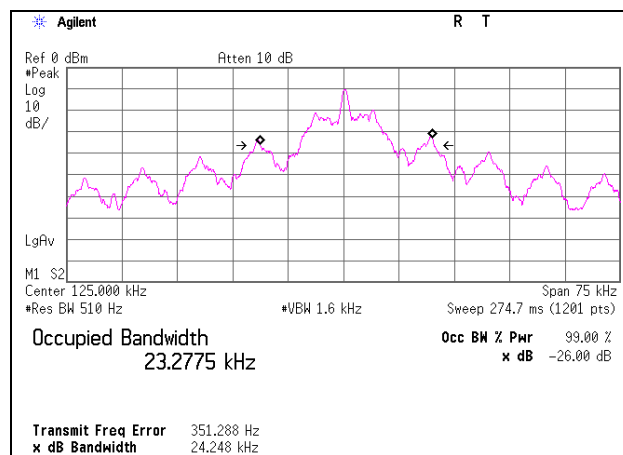
Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

-26 dB Bandwidth and 99 % Occupied Bandwidth

Report No.	13261924H	No.1
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 1	

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
24.248	23.2775



*It was confirmed that there was no difference by the input voltage.

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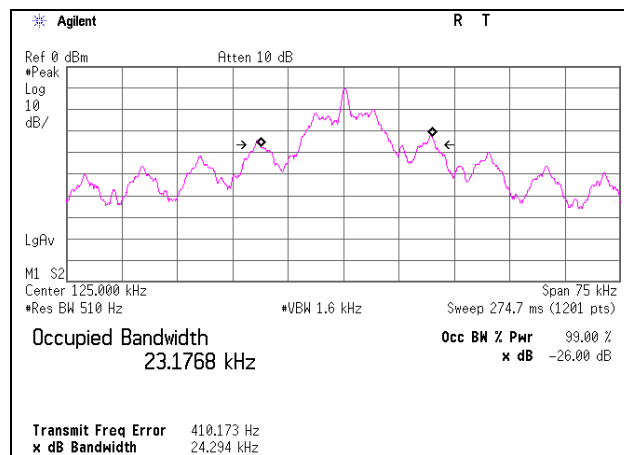
Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

-26 dB Bandwidth and 99 % Occupied Bandwidth

Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 2	

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
24.294	23.1768



*It was confirmed that there was no difference by the input voltage.

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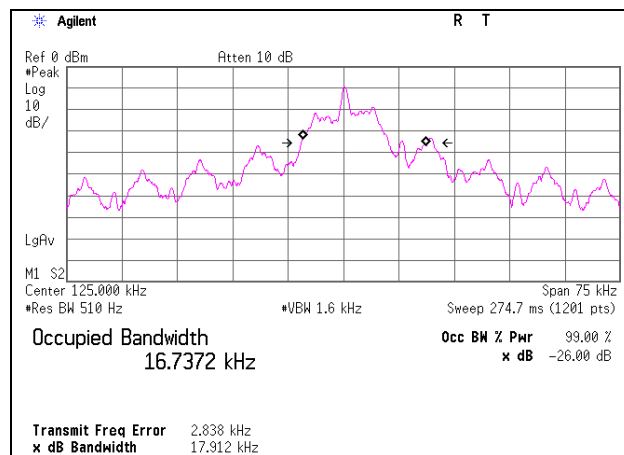
Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

-26 dB Bandwidth and 99 % Occupied Bandwidth

Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 3	

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
17.912	16.7372



*It was confirmed that there was no difference by the input voltage.

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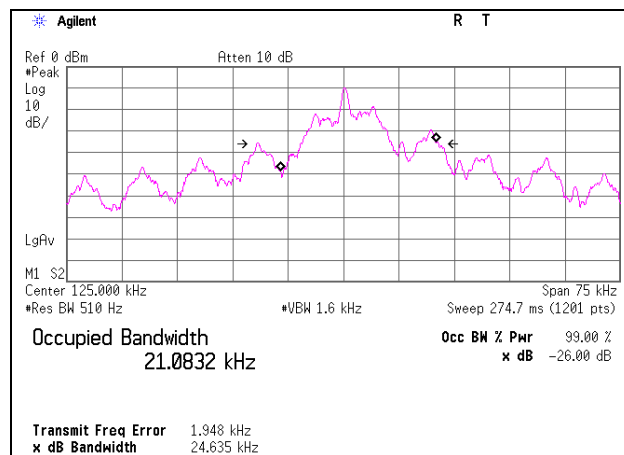
Telephone : +81 596 24 8999

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-26 dB Bandwidth and 99 % Occupied Bandwidth

Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 4	

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
24.635	21.0832



*It was confirmed that there was no difference by the input voltage.

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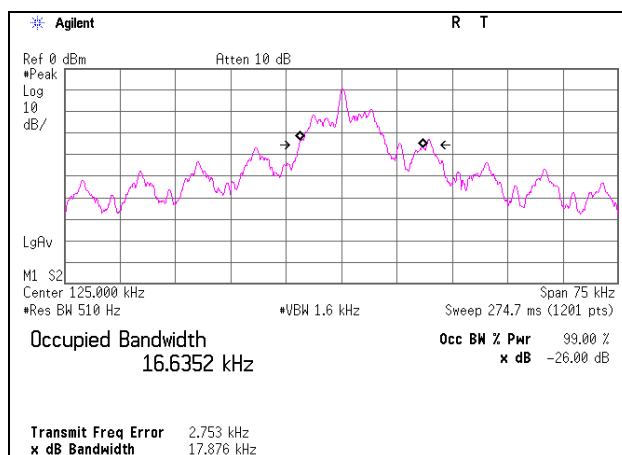
Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

-26 dB Bandwidth and 99 % Occupied Bandwidth

Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 5	

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
17.876	16.6352



*It was confirmed that there was no difference by the input voltage.

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-26 dB Bandwidth and 99 % Occupied Bandwidth

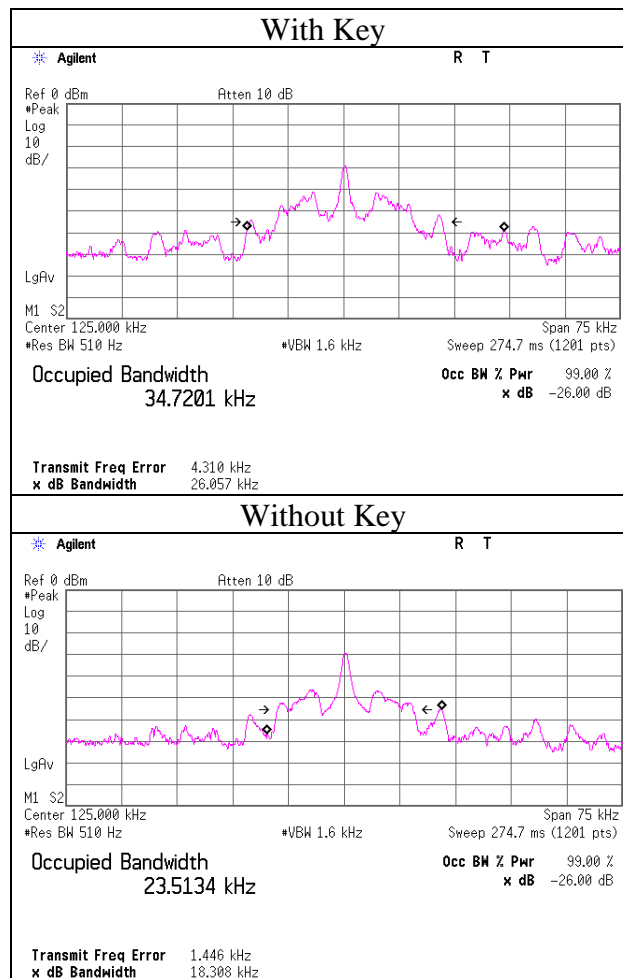
Report No.	13261924H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.1
Date	March 8, 2020	June 30, 2020
Temperature / Humidity	22 deg. C / 47 % RH	23 deg. C / 62 % RH
Engineer	Akihiko Maeda	Akihiko Maeda
Mode	Mode 6	

With Key

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
26.057	34.7201

Without Key

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
18.308	23.5134



*It was confirmed that there was no difference by the input voltage.

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APPENDIX 2: Test instruments

Test equipment

Test Item	Local ID	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
RE	MAEC-01	141998	AC1_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 10m	DA-06881	06/18/2018	24
RE	MOS-27	141566	Thermo-Hygrometer	CUSTOM	CTH-201	A08Q26	01/07/2020	12
RE	MMM-03	141530	Digital Tester	Fluke Corporation	FLUKE 26-3	78030621	08/20/2019	12
RE	MJM-25	142226	Measure	KOMELON	KMC-36	-	-	-
RE	COTS-MEMI-02	178648	EMI measurement program	TSJ	TEPTO-DV	-	-	-
RE	MSA-10	141899	Spectrum Analyzer	Keysight Technologies Inc	E4448A	MY46180655	08/07/2019	12
RE	MTR-09	141950	EMI Test Receiver	Rohde & Schwarz	ESU26	100412	06/27/2019	12
RE	MLPA-01	141254	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100017	10/04/2019	12
RE	MCC-143	141413	Coaxial Cable	UL Japan	-	-	06/07/2019	12
RE	MAT-08	141213	Attenuator(6dB)	Weinschel Corp	2	BK7971	11/14/2019	12
RE	MPA-13	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/10/2020	12
RE	MCC-03	141215	Coaxial Cable	Fujikura/Suhner/TSJ	5D-2W/3D-2W/ RG400u/ RFM-E421(SW)	-/01068(Switcher)	06/27/2019	12
RE	KBA-05	141198	Biconical Antenna	Schwarzbeck	VHA9103+BBA9106	2513	08/23/2019	12
RE	MLA-20	141264	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	9111B-189	08/23/2019	12
RE	MCC-02	141350	Coaxial Cable	Suhner/storm/Agilent/TSJ	-	-	06/27/2019	12
RE	MPA-19	141585	Pre Amplifier	MITEQ	MLA-10K01-B01-35	1237616	02/10/2020	12

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item:

RE: Spurious emission

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